3rd T4CM - Type IV ILC Cryomodule Meeting

22-24 January 2007

INFN Milano - Laboratorio LASA

Piezo ceramics for LLRF

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WHY PIEZO CERAMICS ARE NEEDED IN SUPERCONDUCTING RF SYSTEMS?

Motivation (1/3)

Why do we need a Lorentz force detuning compensation system?

The cavities are pulsed at high field.

The field generates the radiation pressure, which interacts with cavity walls.

The cavity changes its dimensions,

The change of the resonant frequency of the cavity,

The master oscillator frequency is constant.

De-tuned cavity

Motivation (2/3)

Why do we need a Lorentz force detuning compensation system?



Motivation (3/3)

How to maintain the constant phase and amplitude during the RF pulse ?

- 1. Additional RF power for field control could be used
- 2. Passive detuning system (stiffness rings, stiffer cavity, fixture) could be used
- 3. Active detuning system with piezoelectric and/or magnetostrictive device could be used

WP8 Main Tasks

8.1 UMI (coaxial) tuner

8.2 Magnetostrictive tuner

8.3 CEA tuner

8.4 Piezo characterization





DESY





WHERE PIEZO CERAMICS ARE USED?

Examples:

- •Coaxial Blade Tuner
- •CEA Tuners I & II



The INFN Blade-Tuner



Dressed Cavity: 3D Model and Dimensions





Assembling the Tuner

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The first tests are foreseen at DESY, by the end of the year and at Fermilab in January (February) '07, in the Horizontal Test facilities, after the final tuner integration with 1.3 GHz 9-cell SC cavities.



Complete assembly provided with leverage mechanism and stepping motor

Blade Tuner Details



This value has been obtained in quasi-static conditions: no dynamic forces were considered





CEA Tuner







Principles of operation of tuning system

The wall thickness of the XFEL cavities has been chosen to be 2.8 mm, and the individual cells are stiffened with rings. As a consequence, the total change of the volume can be compensated by a cavity length change.



A piezoelement replaces one of the fixing rods. By applying the voltage the piezo pulls the cavity and changes its internal resonance frequency.

Piezos in CEA Tuner



The New Saclay Tuner for XFEL

New design with piezos

- · CARE/JRA-SRF
- SOLEIL upgrades
- larger rigidity



- Fabrication of 2 tuners since beginning of 2005
- 12 NOLIAC piezos, 2 PHYTRON stepping motors ordered
- Coll. with IPN Orsay: CEA send NOLIAC piezos to IPN for characterization, and IPN send P.I. piezos for tests on tuners
- Coll. with INFN-Milano for measurement with stress sensors @ 2K





Piezo Stack Actuators



Tests with two different piezo stacks



Piezo support



NOLIAC PZT stack actuator L= 30 mm V_{max} = 200 V



PICMA PZT stack actuator L= 36 mm V_{max} = 120 V

References for Tuners

Coaxial Blade Tuner

D. Barni, A. Bosotti, C. Pagani, R. Lange, H.B. Peters, "A New Tuner For TESLA", Proceedings of EPAC2002, Paris, France, p. 2205.

C. Pagani, A. Bosotti, P. Michelato, N. Panzeri, P. Pierini, "Improvement of the Blade Tuner Design for Superconducting RF Cavities", Proceedings of PAC2005, Knoxville, TX, USA, p. 3456.

C. Pagani, A. Bosotti, P. Michelato, R. Paparella, N. Panzeri, P. Pierini, F. Puricelli, G. Corniani, CARE-Note-2005-021-SRF.

CEA Tuner I & II

P. Bosland, Bo Wu DAPNIA - CEA Saclay Mechanical study of the « Saclay piezo tuner » PTS (Piezo Tuning System) CARE-Note-2005-004-SRF

Bosland, P; Devanz, G; Jacques, E; Luong, M; Visentin, B; Wu, B - CEA-Saclay Tuners Ready for Tests, CARE-Report-06-012-SRF

The Conceptual Design Report for the TESLA Test Facility (TTF) Linac, Version 1.0

Piezo ceramics characterization

- The producers don't supply information about the behavior of piezos at LHe temperatures and there is very few literature.
- So the piezo ceramics static and dynamic behavior at cryogenic temperatures must be investigate prior to use them in SC structures.



Guidelines for piezo choice	Blade tuner piezo specifications - Working point, 2K -	Needed properties, for piezo at room temperature	
Blocking force	4 kN open loop To guarantee almost full stroke when working against the cavity spring load	Cross section higher then 10 x 10 mm ² blocking force is mainly not affected by temperature	
Max. stroke	4 μm60 μmTo provide the designed fast tuning rangeadvisableadvisableadvisable		
Stiffness	>> 25 N/µm To preserve the total tuner/helium tank stiffness k > 100 N/µm		
Control speed	> 0.01 µm/µsec To avoid the control loop radically exceeding actuator intrinsic dynamic	Resonance frequency higher then 10 kHz, with no applied load	
Load limit	> 10 kN To avoid damaging during assembling, conditioning or cooling down		
Size	≤ 15 x 15 x 72 To fit in the current tuner design		
Control voltage	V _{max} < 200 V low voltage piezo electric actuators, to limit piezo self-heating in cryogenic environment		
Long life	1.5 10° cycles Equivalent to 10 years of standard operation at 2K	No explicit guarantees from manufacturers! Only some guidelines: Preload: 10-30% of load imit No tensile forces Vacuum, clean env.	

"Characterized" Piezos

PROPERTIES	unit / tolerance	Holiac	Noliac	Epcos	PI	N oliac	Piezomechanik
		SCMA/S1/A/10/10/40/200/60/4000	SCMA/S2/A/15/15/70/200/100/9000	LN 01/8002	P-888.90	SCMAS/S1/A/10/10/80/200/42/6000	Pst 150/10
Room Temperature							
material		medium soft doped PZT-S1	medium soft doped PZT-S2	PZT-nd34	PZT-PIC 255	medium soft doped PZT-S1	
caselpreload		no	no	no	no	no	Yes / 400N
length	nm	$40 \pm 0,5$	70 ± 0,8	30	36	30 ± 0,5	64
active length	nm	38.5	68.5		33.84	27.5	
cross section	mm x mm	(10 x 10) ± 0,2	(15 x 15) ± 0,3	6,8 x 6,8	10 x 10	(10 x 10) ± 0,2	
Number of layers		266	490		300	196	
Average layer thickness	um	140	140		113	140	
Young modulus	ktl/mm2	45	47	51	48.3	45	
stiffness	kN/um	0,1125	0,151	0.083	0.105	0.15	0.035
max. stroke	μm	60 ± 9	100 ± 13	40	35 ± 3,5	42 ± 6,3	80
blocking force (open loop)	N N					6000	3500
blocking force (closed loop)	N	4000 ± 800	9000 ± 1400	3200	3600 ± 720	4000 ± 800	
max. load	N	12000	27000		10000	12000	
Parallel Res. Frequency @ no load	kHz	38		52	40	51	
density	kg/m3	7,7 x 10*3	7,5 x 10^3	7,75 x 10^3	7,8 x 10^3	7,7 x 10^3	
min. voltage		0	0	0	-20	0	-30
max. voltage	v	200	200	160	120	200	150
control speed - unloaded	V/µs			1.6			
charge current	A			20			
capacity: nominal	μF	8	40	2.1	12.4	5.7	
measured	μF	8.3		2.5	13.6	6.2	
Loss Factor	tanō	0.017		0.019	0.015	0.017	
Thermal Expansion Coefficient (Multilayer)	Ppm/K	-2.5				-2.5	
Cryogenic Measurements, T = 4.2 K							
Parallel Res. Frequency @ no load	kHz			62	48.5	60	
Capacity @ no load	μF				5.7		
Cryogenic Measurements, T = 2 K							
Parallel Res. Frequency @ no load	kHz				52.5		
Capacity @ no load	μF				3.5		
Expected Values							
Capacity @ T = 4.2 K	μF			0.125		0.31	
Capacity @ T = 2 K	μF	1	4				
Stroke @ T = 4.2 K	μm	7	12	8	7	8.4	16
Stroke @ T = 2 K	μm						
Parallel Res. Frequency @ no load, T = 4.2 K	kHz	46	et				
Parallel Res. Frequency @ no load, T = 2 K	kHz	50	52				. 61.
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Piezos "involved" in LLRF operations



Devices calibration "facility" example



How the force on the DUT is generated

Indirect measure of preload

Indirect measure of the preload on piezoelectric actuator: the position of some resonances in the piezo impedance is linked to the applied force



Piezo resonance frequency response vs applied load

Calibration Curve



Each piezo to be tested is hosted in a properly shaped aluminium support to avoid any nonvertical force component on the ceramic element;



the support element is then fixed inside the cold box



Nollac amplitude @150 kg

Piezo Life-Time Test 1/2

The purpose of this test is to investigate the behavior of piezoelectric ceramics in condition equivalent to 10 years of operation as actuator in active frequency tuner for ILC superconducting cavities (SC).

To do this a **Physik Instrumente PI P-888.90 PIC255** piezoelectric ceramic has been cooled down in LN2 and has been excited uninterruptedly for about one month up to its limits, sustaining about 1.5x10⁹ cycles of switching, up to nearly the maximum stroke, a good estimate of ten years as actuator for ILC cavities.

Experimental apparatus block diagram

PROPERTIES	PI P-888.90	Unit
Material	PZT-PIC 255	
Length	36	mm
Cross section	100	mm²
Max. stroke	35	μm
Blocking force	3600	N
Res. frequency @ no load	40	kHz
Min. voltage	-20	V
Max. voltage	120	V
Capacity - nominal	12,4	μF
Capacity - measured	13,6	μF

Main features and parameters of the piezo



Insert "functional" scheme

Piezo Life-Time Test 2/2

	Before	After
Capacity [uF]	13.6	13.56
Res. Freq [kHz]	45.9	45.2
Max stroke [um]	40.2	38.3

Main piezo parameters checked



Start	26 Nov 2004
Stop	20 Dec 2004
Hours	622
Cycles	1.505x10 ⁹
Sine Wave Amplitude	-20V ÷ +120 V
Frequency	117 Hz for 4 days 497 Hz for 6 days 997 Hz for 16 days
Average Preload	1.25 kN
Max Current [rms]	< 200 mA
Average Temperature	81 K

Main features of the life time test



Radiation Hardness tests with fast neutrons at T=4.2 K





Test stand for 4 PICMA actuators and measurement of total dose distribution (x10¹⁴ n/cm²)





Radiation tests finished: 3 Runs performed, 11 actuators evaluated



Irradiations insert in front of the beam-line

No anomalous behavior, no damage observed during irradiations with fast neutrons in liquid helium (T=4.2 K)







Piezostack characterization – summary



Dimensions: **10x10x36mm** Manufacturer: **PI**



Dimensions: **10x10x30mm** Manufacturer: **NOLIAC**

Maximum displacement (stroke) at 1.8K >3μm Actuators suited for VUV-FEL, X-FEL and even ILC (≈1kHz⇔~35MV/m)

No damage and no electrical breakdown observed during all tests Lifetime at LN₂>1.5*10⁹ cycles (INFN)⇔5Hz for 10 years of operation

No damage caused by neutron irradiation, only heating observed Dose of 2-3*10¹⁴ n/cm² in 8h

> Facility for piezostack investigation is set in IPN Orsay and INFN Milan



Piezos in operation



- FLASH at DESY (piezos inserted in cav #5 of module 1 tuner)
- CHECHIA at DESY
- CryHoLab at CEA Saclay
- CMTS at DESY (Cryo # 6 \Rightarrow 8 cavities equipped with fast tuners)



Test In CHECHIA







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Blue: With piezo Frequency stabilization Red: Without piezo during RF pulse using a Frequency detuning of 500 Hz compensated piezoelectric tuner voltage pulse (~100 V) on the piezo. No resonant compensation 500 Σ100 Piezo compensation off on Actuator-Piezo Piezo compensation on 400 50 300 0 200 Voltage 100 -50 \ -2 detuning[Hz] Π 3 -1 к 10¹³ -100 -200 0 -300 5 .0.2 -400Current -0.3 -1 0 2 З -2 -500 2000 1000 1200 1600 1800 Ó. 200 400 600 800 1400 t[s] к 10¹³ t[us] Lutz Lilje DESY -MPY-07.03.2005 INEN

Piezo Tests in FLASH





INEN DESY

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Piezo Control Panel Control panel is implemented in MATLAB and in the DSP board.

Final goal is to integrate the algorithms with LLRF system in FPGA

Algorithms implemented in SimCon board











Measurement done in cavity 5, ACC1 VUV-FEL field gradient ~20 MV/m





Result of beam energy drift





The energy increases by almost 600keV (or 0.5%) due to the fast tuner applied to only one cavity (cav5/ACC1).

The drift is caused by the klystron. Feedback in ACC1 was switched off.





cex-PN



Tests On Module # 6 cavities in CMTB at DESY (work in progress!)

The eight cavities inserted in cryomodules # 6 are equipped with active tuners with 2 PI piezos

Analysis of the cavity ringings

While the module was operated at 20 MV/m, 10 Hz rep. rate, the cavity oscillations induced by the RF pulse was recorded using the piezo as a sensor, then the corresponding spectrum has been computed showing an estimation of the RF-to-Piezo transfer function



LFD compensation on CMTB cav3

While the module was operated at 20 MV/m, 10 Hz rep. rate one piezo has been used to compensate the detuning of the cavity during the flat-top, therefore leaving a static detuning value.



Then both amplitude and delay of the piezo pulse has been swept around in order to obtain the best detuning compensation. **The best result is shown**, it corresponds to a **piezo pulse amplitude of 22.7 V and to a time window of 640 μs between piezo and RF pulse** (1.8 ms delay from master trigger). The delay of the piezo pulse from the master trigger has been set to a safety value of 2 ms, that correspond to a time window of 440 µs between piezo and RF pulse.

The the amplitude of the piezo pulse has been raised. **The compensating effect is visible**. Even an over-compensating effect of the piezo pulse can be seen at higher amplitudes



Scope traces during LFD compensation

The traces of the scope in use during these measurements are shown. The 2 visible traces of interest are the violet one, the actuator piezo signal (the piezo driver input signal), and the green one, the readout from the sensor piezo (the output of the differential amp.)



The best pulse for cav3 applied to all cavities

(To save time due to the incoming warm-up dead line) the best piezo pulse found for cavity 3 has been applied to all other cavities, in order also to verify the differences among them.

Though the compensating effect is clear for every cavity, still significant differences are evident.



1.8 K Measurements in CryHoLab

- Static range for one piezo :
 - ∆f = 800 Hz for a driving voltage of 100 V DC (Not tested at higher voltage)
- The measured temperature of the piezos is between 20 and 30 K
- Slow tuner range : 500 kHz
- Transfer function measurements





1.8 K PZT→∆f transfer function in CryHoLab





 Piezo to ∆f TF : large number of modes. The PTS is likely to couple longitudinal and transverse modes of the cavity

Mechanical delay 400 μ s (propagation time in the structure)

1.8 K Pulsed operation in CryHoLab

- RF source : 1.5 MW, 1ms pulse, 6.25 Hz max •
- Rep. rate for the LFD experiments is 0.87 Hz
- DESY TTF-III coupler Measured Q_{ext} = 1.34 10⁶
- Maximum E_{acc} = 25 MV/m, limited by field emission on the test cavity (C45)
- RF pulse is different from TTF pulse:
 - Faster rise time = 200 µs instead of 500 µs
 - Same flat top 800 µs



Piezo signal @ 25 MV/m



- Piezo signal is the superposition of the response to Lorentz force (≈ impulse response) and to background vibrations (He, pumps,site) which cause microphonics
- Major contribution of LFD through the 306 Hz mode (Qm ≈100)



LFD compensation @ 25 MV/m

minimize the cavity voltage phase excursion during the flat top

Parameters for a simple PZT driving pulse: pre-delay, amplitude, rise time



The **detuning of -240 Hz** is derived using a numerical model of the cavity and fitting the measured amplitude and phase.

With compensation the detuning is reduced to 20 Hz peak-peak during the flat top.

Summary of tests results

- The collected results of the tests in various labs show that LFD compensation with piezos is possible.
- More than 1 kHz detuning has been corrected with resonant compensation, less with single pulses non resonant modes.
- Other (longer and larger) piezos have to be tested.
- Coaxial blade tuners have still to be tested
- Furthermore the first results in CMTB at DESY seems to be promising. Next test by the end of January with higher voltages and different pulses.
- More work has to be done to optimize piezo-cavity interaction to be more efficient.
- Possibility to compensate microphonics still to be investigated.

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Tuner Test Bench

A simple test bench for tuners can be realized using a 1.3 GHz mono-cell cavity, easily upgradable to a real 9-cell cavity.



The cavity dress is designed to accommodate the blade tuner and the piezo actuators, in order that the piezo elements see the stiffness of the true tesla cavity.

The lateral plates can be designed in order to accommodate a proper gasket and allow a cryogenic test of the assembly. This solution can be attained by machining proper groves on the end plates.

Acknowledgements

- Most of the work presented in here is not my own but other people's, as can be seen from the many slides I have borrowed from other presentations.
- So, without listing the names (I surely would forgotten someone) I wish to thank you all these people, especially the ones from:
 - the TTF-TESLA collaboration
 - SRF WP8 (tuner) CARE working package

CARE WP8 Involved Laboratories

DESY - *S. Simrock, L. Lilje, C. Albrecht and Everybody Else not listed here..* Deutsches Elektronen-Synchrotron

TUL-DMCS - A. Napieralski, P. Sekalski, M. Grecki & E.E.... Department of Microelectronic and Computer Science, Technical University of Lodz, Poland

INFN – A. Bosotti, N. Panzeri, R. Paparella & E.E.... Italian National Institute for Nuclear Physics, Milan, Italy

IN2P3 - M.Fouaidy & E.E....

Institut National de Physique Nucléaire et de Physique des Particules, Orsay, France

CEA Saclay – *P. Bosland & E.E...* Commissariat à l'Energie Atomique